



Power MOSFETS

DATASHEET

LM1A092NAK8A

N-Channel
Enhancement Mode MOSFET

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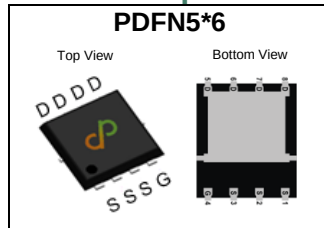


Quality Management Systems

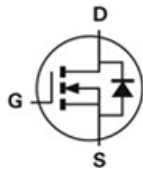
ISO 9001:2015 Certificate

N-Channel Enhancement Mode MOSFET

Pin Description



Symbol



Product Summary

Symbol	N-Channel	Unit
V_{DS}	100	V
$R_{DS(ON)-Max}$	9.2	m Ω
ID	58	A

Feature

- Advanced trench cell design
- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- 100% UIS and Rg Tested

Applications

- Motor drivers
- DC-DC Converter

Ordering Information

Orderable Part Number	Package Type	Form	Shipping	Marking
LM1A092NAK8A	PDFN5*6	Tape & Reel	5000 / Tape & Reel	1A092 □□□□□□

Absolute Maximum Ratings ($T_J=25^{\circ}\text{C}$ Unless Otherwise Noted)

Symbol	Parameter		N-Channel	Unit
V _{DSS}	Drain-Source Voltage		100	V
V _{GSS}	Gate-Source Voltage		±20	
T _J	Maximum Junction Temperature		150	°C
T _{STG}	Storage Temperature Range		-55 to 150	°C
I _{DM} ^①	Pulse Drain Current Tested	T _c =25°C	106	A
I _D	Continuous Drain Current	T _c =25°C	58	A
		T _c =100°C	36	
P _D	Maximum Power Dissipation	T _c =25°C	50	W
		T _c =100°C	20	
I _D ^③	Continuous Drain Current	T _A =25°C	13	A
		T _A =70°C	10	
P _D ^③	Maximum Power Dissipation	T _A =25°C	2.5	W
		T _A =70°C	1.6	
I _{AS} ^②	Avalanche Current, Single pulse	L=0.1mH	27	A
E _{AS} ^②	Avalanche Energy, Single pulse	L=0.1mH	36	mJ

Thermal Characteristics

Symbol	Parameter		Rating	Unit
$R_{\theta JC}$	Thermal Resistance-Junction to Case	Steady State	2.5	°C/W
$R_{\theta JA}^{\textcircled{3}}$	Thermal Resistance-Junction to Ambient	Steady State	50	°C/W

Note ① : Max. current is limited by bonding wire

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C

Note ③ : Surface Mounted on 1in^2 FR-4 board with 1oz.

N-Channel Electrical Characteristics ($T_J=25^{\circ}\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Electrical Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _{DS} =250uA	100	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =80V, V _{GS} =0V	-	-	1	uA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =250uA	1	2	3	V
I _{GSS}	Gate Leakage Current	V _{GS} =±20V, V _{DS} =0V	-	-	±100	nA
R _{DS(ON)} ^④	Drain-Source On-state Resistance	V _{GS} =10V, I _{DS} =20A	-	7.6	9.2	mΩ
		V _{GS} =4.5V, I _{DS} =20A	-	11	14	
gfs	Forward Transconductance	V _{DS} =5V, I _{DS} =10A	-	22.3	-	S
Dynamic Characteristics [®]						
R _G	Gate Resistance	V _{GS} =0V,V _{DS} =0V, Freq.=1MHz	-	0.8	-	Ω
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =50V, Freq.=1MHz	-	1910	-	pF
C _{oss}	Output Capacitance		-	506	-	
C _{rss}	Reverse Transfer Capacitance		-	36	-	
td(ON)	Turn-on Delay Time	V _{GS} =10V,V _{DS} =50V, I _D =1A,R _{GEN} =6Ω	-	9.2	-	nS
t _r	Turn-on Rise Time		-	17.6	-	
t _{d(OFF)}	Turn-off Delay Time		-	32.2	-	
t _f	Turn-off Fall Time		-	69.9	-	
Q _g	Total Gate Charge	V _{GS} =4.5V,V _{DS} =50V I _D =20A	-	22	-	nC
Q _g	Total Gate Charge	V _{GS} =10V,V _{DS} =50V, I _D =20A	-	39.9	-	
Q _{gs}	Gate-Source Charge		-	8.92	-	
Q _{gd}	Gate-Drain Charge		-	10.4	-	
Source-Drain Characteristics						
V _{SD} ^④	Diode Forward Voltage	I _{SD} =10A, V _{GS} =0V	-	0.8	1.1	V
t _{rr}	Reverse Recovery Time	I _F =10A, V _R =50V	-	37	-	nS
Q _{rr}	Reverse Recovery Charge	dI _F /dt=100A/μs	-	35	-	nC

Note ④ : Pulse test (pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$).

Note ⑤ : Guaranteed by design, not subject to production testing.

N-Channel Typical Characteristics

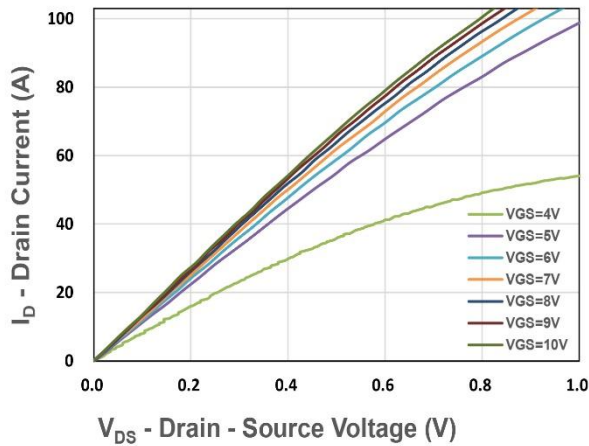


Figure 1. Output Characteristics

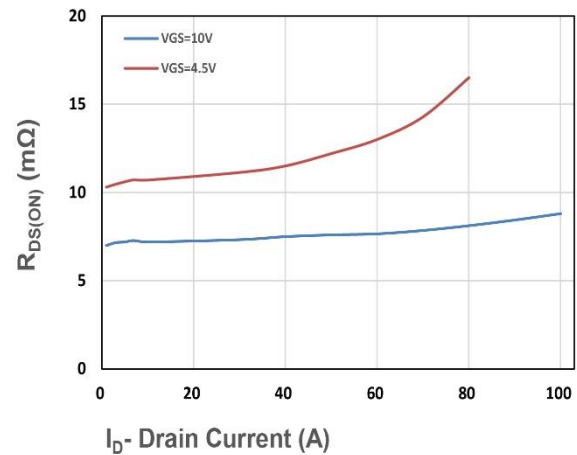


Figure 2. On-Resistance vs. I_D

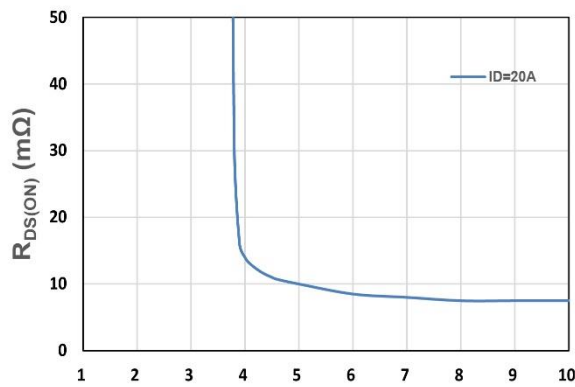


Figure 3. On-Resistance vs. V_{GS}

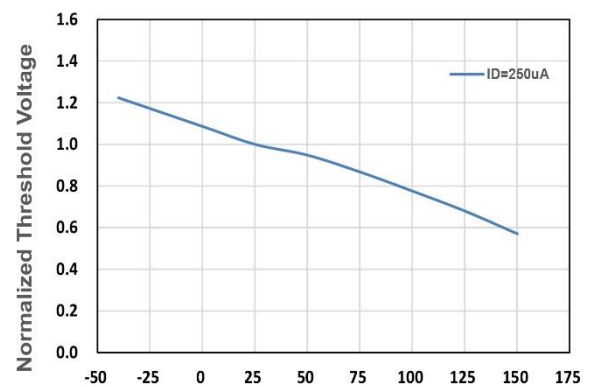


Figure 4. Gate Threshold Voltage

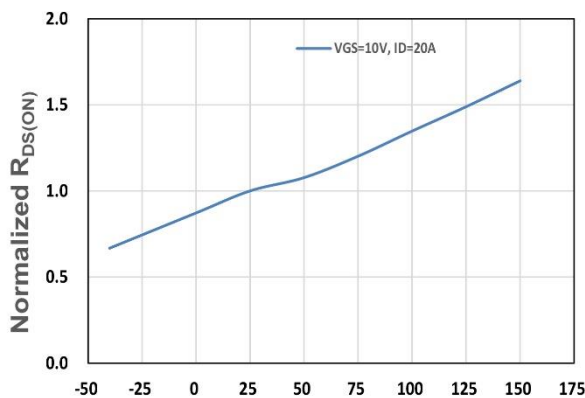


Figure 5. Drain-Source On Resistance

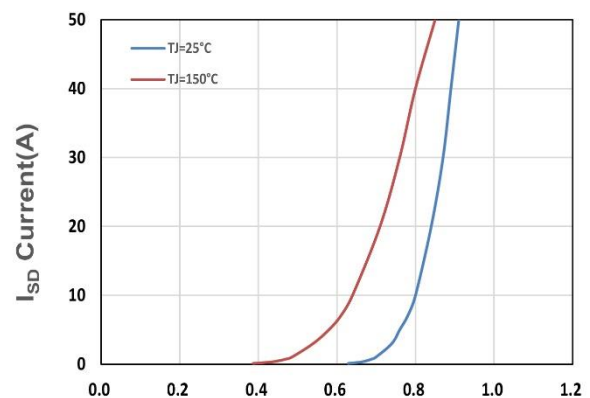
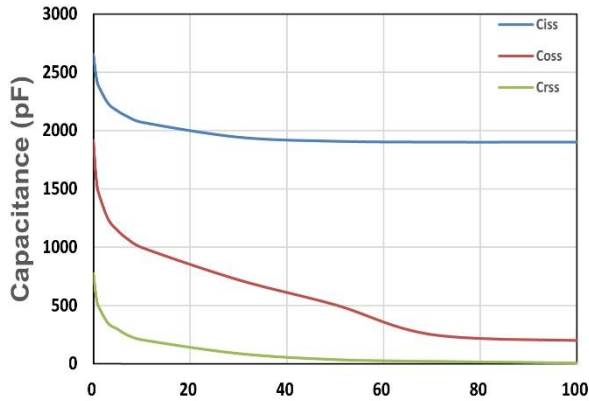
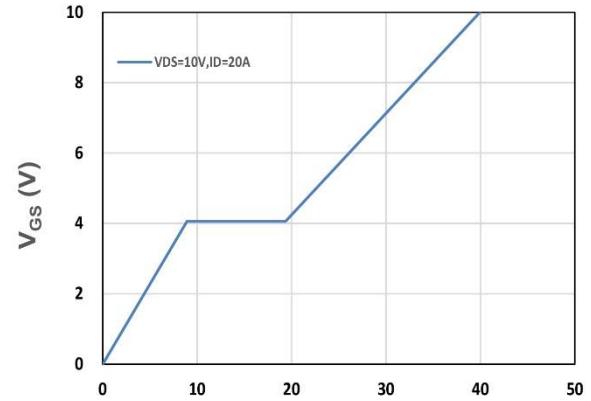


Figure 6. Source-Drain Diode Forward



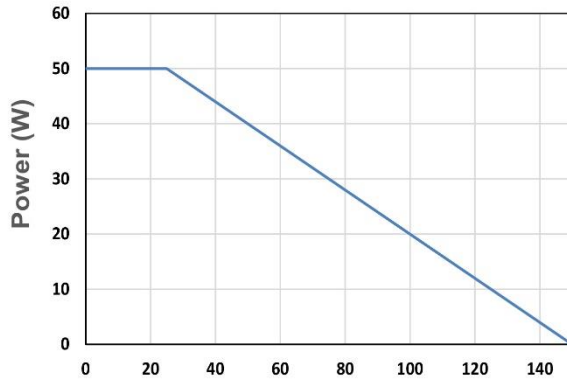
V_{DS} - Drain - Source Voltage (V)

Figure 7. Capacitance



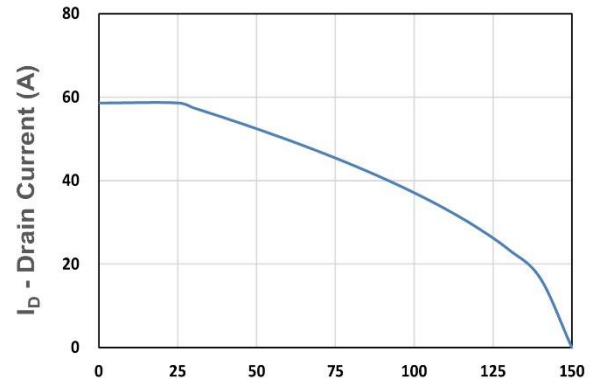
Q_g , Total Gate Charge (nC)

Figure 8. Gate Charge Characteristics



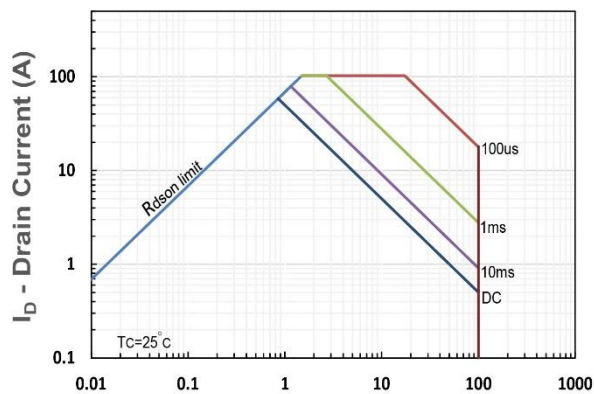
T_J - Junction Temperature (°C)

Figure 9. Power Dissipation



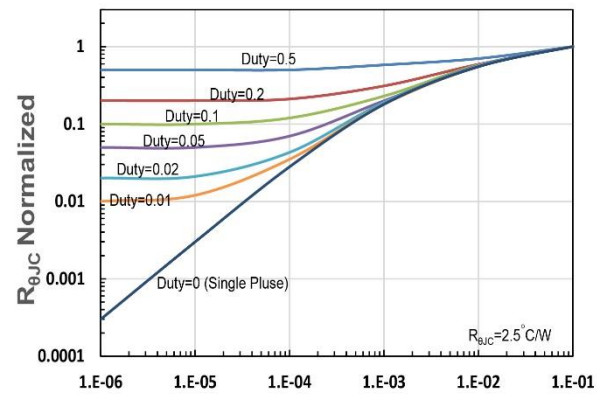
T_J - Junction Temperature (°C)

Figure 10. Drain Current



V_{DS} - Drain-Source Voltage (V)

Figure 11. Safe Operating Area



t_1 , Square Wave Pulse Duration(s)

Figure 12. $R_{\theta JC}$ Transient Thermal Impedance